Se	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/690,068	BOYD ET AL.	
Examiner	Art Unit	
Brian J. Assessor	2114	

SEARCHED			
Class	Subclass	Date	Examiner
714	6	7/22/2007	ВА
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			
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SEARCH I (INCLUDING SEAR)
	DATE	EXMR
EAST - ALL DATABASES	7/22/2007	ВА
INVENTOR SEARCH	7/22/2007	ВА
IEEE	7/22/2007	ВА
GOOGLE	7/22/2007	ВА
ACM	7/22/2007	ВА